

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination 10/679,576 LEHIKONEN ET AL.	
		Examiner Duc M. Nguyen	Art Unit 2685	Page 1 of 1

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*	C	US-2003/0035412 A1	02-2003	Wang et al.	370/352
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	M	US-			

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